# Dual N-Channel Enhancement Mode Power MOSFET

#### Description

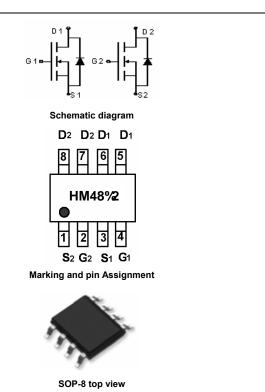
The HM4812 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch and PWM applications.

#### **Genera Features**

- $V_{DS} = 30V, I_D = 7A$  $R_{DS(ON)} < 31m\Omega @ V_{GS} = 10V$ 
  - $R_{DS(ON)} < 43m\Omega @ V_{GS}=4.5V$
- High Power and current handing capability
- Lead free product is acquired
- Surface mount package

#### Application

- Load switch
- •PWM application



#### Package Marking and Ordering Information

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Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM4812	HM4812	SOP-8	Ø180mm	8 mm	3000 units

#### Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	30	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	ID	7	А
Drain Current-Pulsed (Note 1)	I <sub>DM</sub>	30	A
Maximum Power Dissipation	PD	1.4	W
Operating Junction and Storage Temperature Range	$T_{J},T_{STG}$	-55 To 150	°C

### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	R <sub>θJA</sub>	89	°C <b>/W</b>
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#### Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	30	33	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}$ =30V, $V_{GS}$ =0V	-	-	1	μA

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Parameter	Symbol	Condition	Min	Тур	Мах	Unit
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20V, $V_{DS}$ =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1.2	1.6	2.4	V
Drain-Source On-State Resistance	5	V <sub>GS</sub> =10V, I <sub>D</sub> =5A	-	25.5	31	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =4.5V, $I_{D}$ =4A	-	34	43	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =5V,I <sub>D</sub> =5A	-	15	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>	(-1E)()(-0)(	-	255	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz	-	45	-	PF
Reverse Transfer Capacitance	Crss		-	35	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>		-	4.5	-	nS
Turn-on Rise Time	tr	$V_{DD}$ =15V, R <sub>L</sub> =3 $\Omega$	-	2.5	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10V, $R_{GEN}$ =3 $\Omega$	-	14.5	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	3.5	-	nS
Total Gate Charge	Qg		-	5.2	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =15V,I <sub>D</sub> =5A, V <sub>GS</sub> =10V	-	0.85	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	VGS-IUV	-	1.3	-	nC
Drain-Source Diode Characteristics	· · ·					
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =5A	-	-	1.2	V
Diode Forward Current (Note 2)	I <sub>S</sub>		-	-	5	А

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

**2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.

**3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

4. Guaranteed by design, not subject to production

90%

10%

90%

50%

t<sub>d(off)</sub>

**INVERTED** 

**PULSE WIDTH** 

Figure 2:Switching Waveforms

ι t

10%

50%

90%

t<sub>d(on)</sub>

Vout

VIN

10%

## **Typical Electrical and Thermal Characteristics**

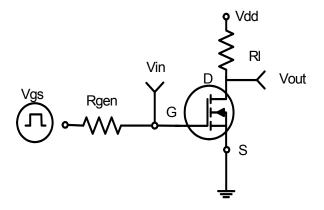
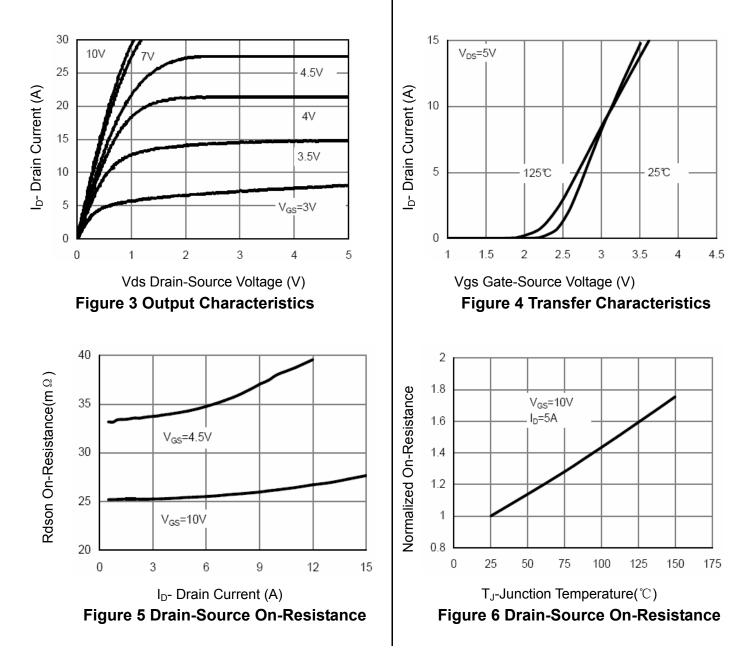
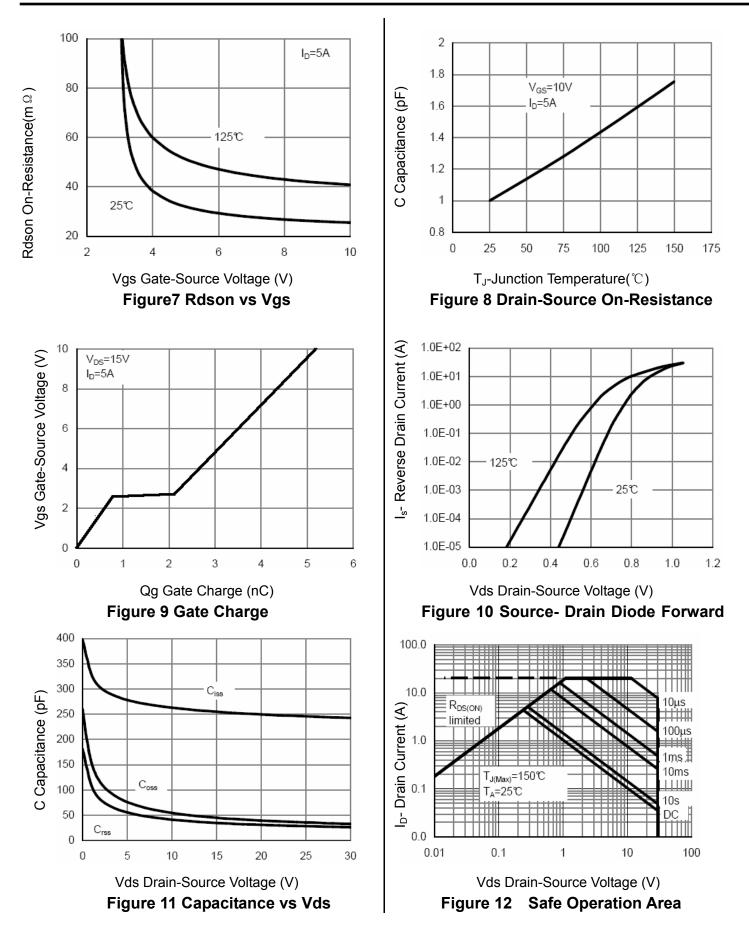
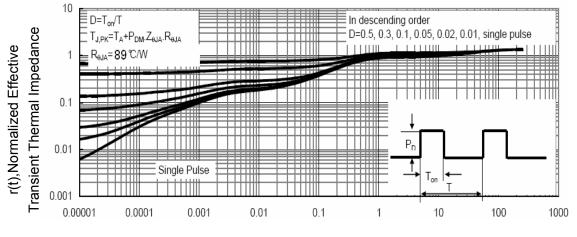


Figure 1:Switching Test Circuit



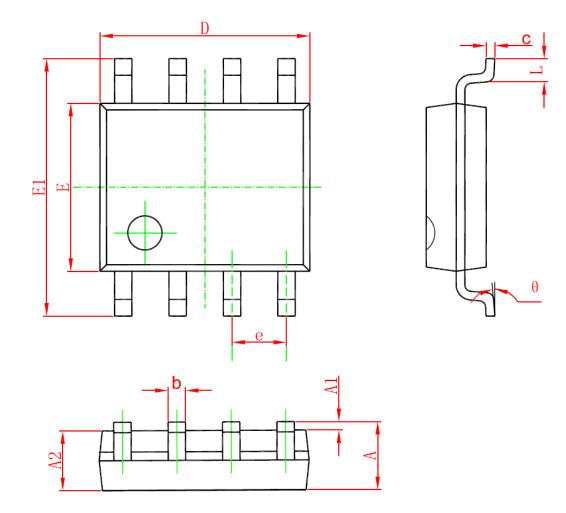
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Square Wave Pluse Duration(sec) Figure 13 Normalized Maximum Transient Thermal Impedance

# **SOP-8 PACKAGE IN FORMATION**



Cumb a l	Dimensions Ir	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
A	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0.013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4.000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1. 270	0.016	0. 050	
θ	0°	8°	0°	8°	

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